Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10586292	TEY ET AL.
Examiner	Art Unit
Pablo N Tran	2618

SEARCHED						
Class	Subclass	Date	Examiner			
455	347,, 300, 301, 293, 349,, 130, 191.1, 189.1, 252.1, 253.1, 311-312, 333-334, 90.3, 550.1, 575.1	9/10/08	PT			
348	162	9/10/08	PT			
257	686, 723, 777, 779, 659, 773, 728, 700, 702, 706, 723- 724	9/10/08	PT			
343	702, 772	9/10/08	PT			
327	356, 359, 355, 566,	9/10/08	PT			

SEARCH NOTES			
Search Notes	Date	Examiner	
East/West	9/17/08	PT	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

	/P. N. T./ Primary Examiner.Art Unit 2618
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